

Neuromorphic electronic behavior in
transition metal oxide systems

From resistive switching to artificial synapses and neurons

Marcelo Rozenberg

LPS Orsay

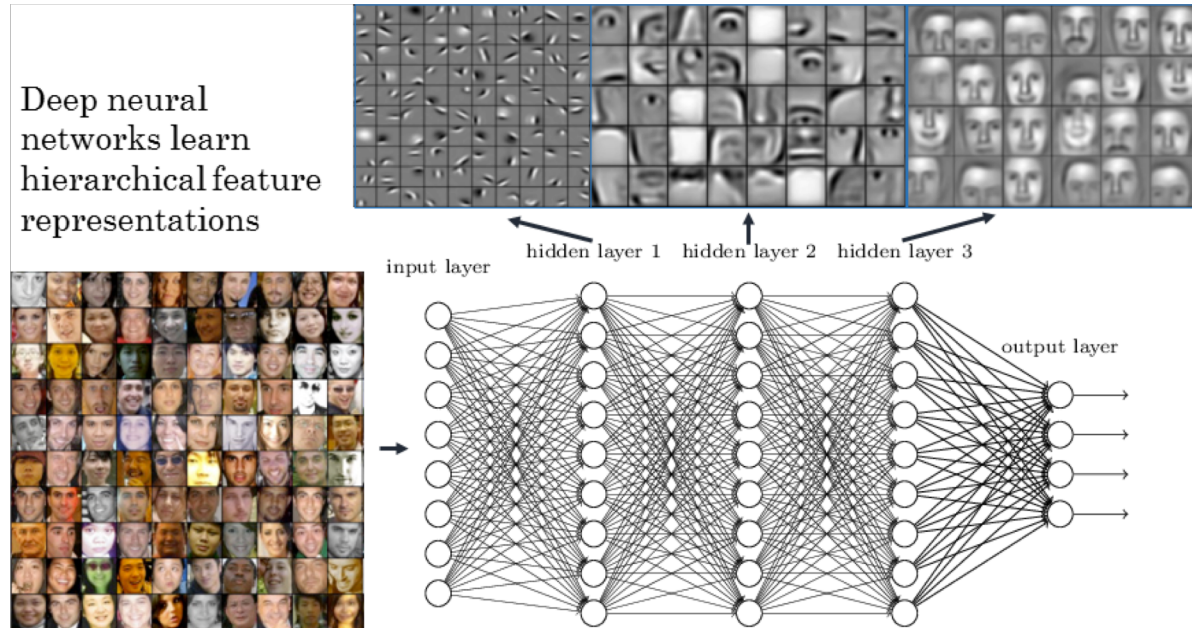
CNRS – Université Paris-Sud

Neuromorphic circuits and computation is a very hot topic

Bio-chips (CMOS hardware)



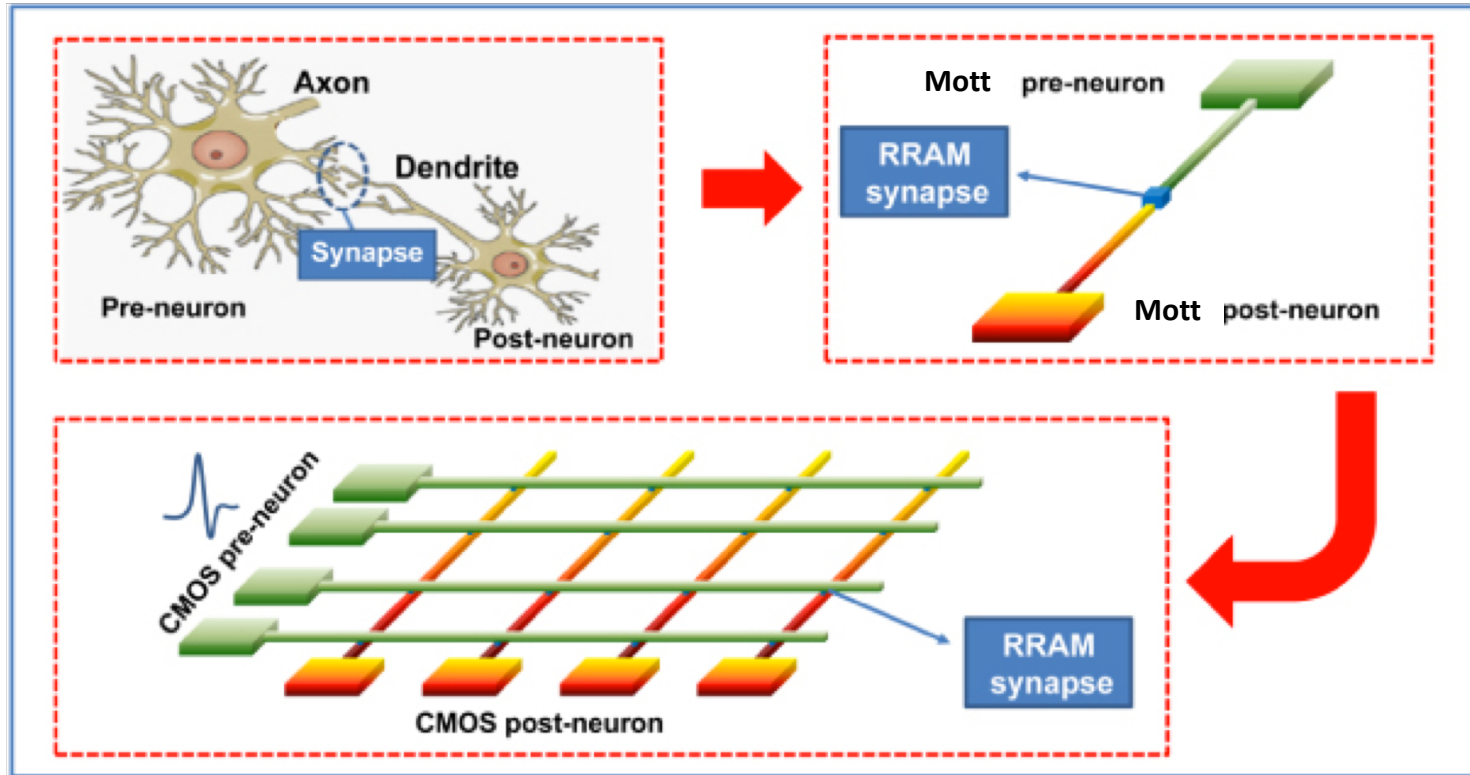
Deep Neural Networks (software)



- DARPA's Synapse Program
- EU Human Brain Project
- Facebook
- Google (DeepMind, AlphaGo)

human brain:
 10^{11} neurons
 10^{15} synapses

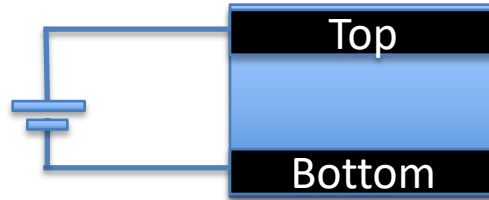
Novel electronic devices for neuromorphic systems



Park et al Nanotechnology '13

Neurons and Synapses:
Based on **Resistive Switching**
Great opportunity for **oxyde electronics** !

What is Resistive Switching (in TMOs) ?



It is the sudden change in *resistance* due to a strong electric stress (V or I) on a simple two-terminal device (capacitor-like)

1) The change may be permanent, ie ***non-volatile***, and ***reversible***

(Obvious) Application as electronic memory device: **RRAM** (aka: ReRAM, OxRAM, memristors)

2) The change may be non-permanent ie ***volatile***

Less obvious applications are practical realizations of:

artificial synapses (1) and ***artificial neurons*** (2)

New functionalities of TMO materials

1 - Non-volatile Resistive Switching

Basic concepts

Physical mechanism

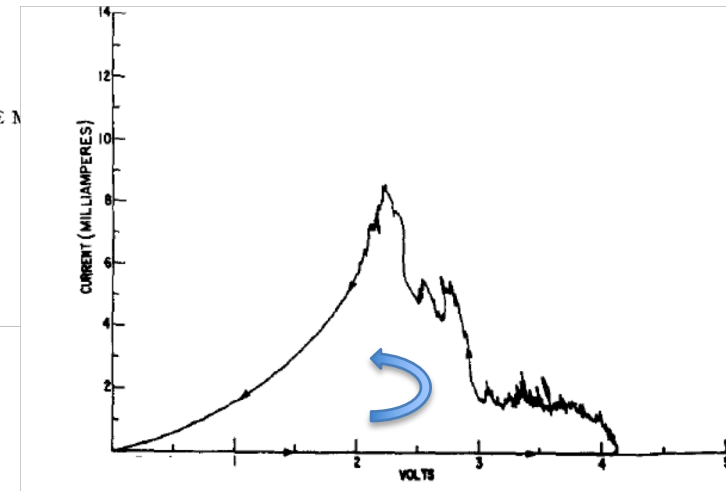
Research in “memristors” is not new

Were not « discovered » in 2008 in HP...it begun more than 60 years ago...

JOURNAL OF APPLIED PHYSICS VOLUME 33, NUMBER 9 SEPTEMBER 1962

Low-Frequency Negative Resistance in Thin Anodic Oxide Films

T. W. HICKMOTT
General Electric Research Laboratory, Schenectady, New York
(Received February 5, 1962)



New Conduction and Reversible Memory Phenomena in Thin Insulating Films

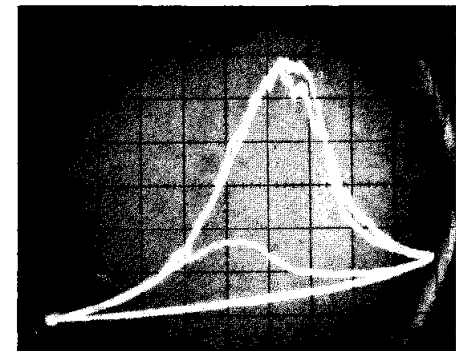


FIGURE 10. Photograph of X-Y oscilloscope $V-I$ trace for a complete voltage cycle between 0 and 9 V at (a) 300 °K and (b) 77 °K. Scales are $x = 1$ V/div, $y = 10$ mA/div.

J. G. SIMMONS; R. R. VERDERBER

Proceedings of the Royal Society of London. Series A, Mathematical and Physical Sciences, Vol. 301, No. 1464 (Oct. 3, 1967), 77-102.

VOLUME 21, NUMBER 20

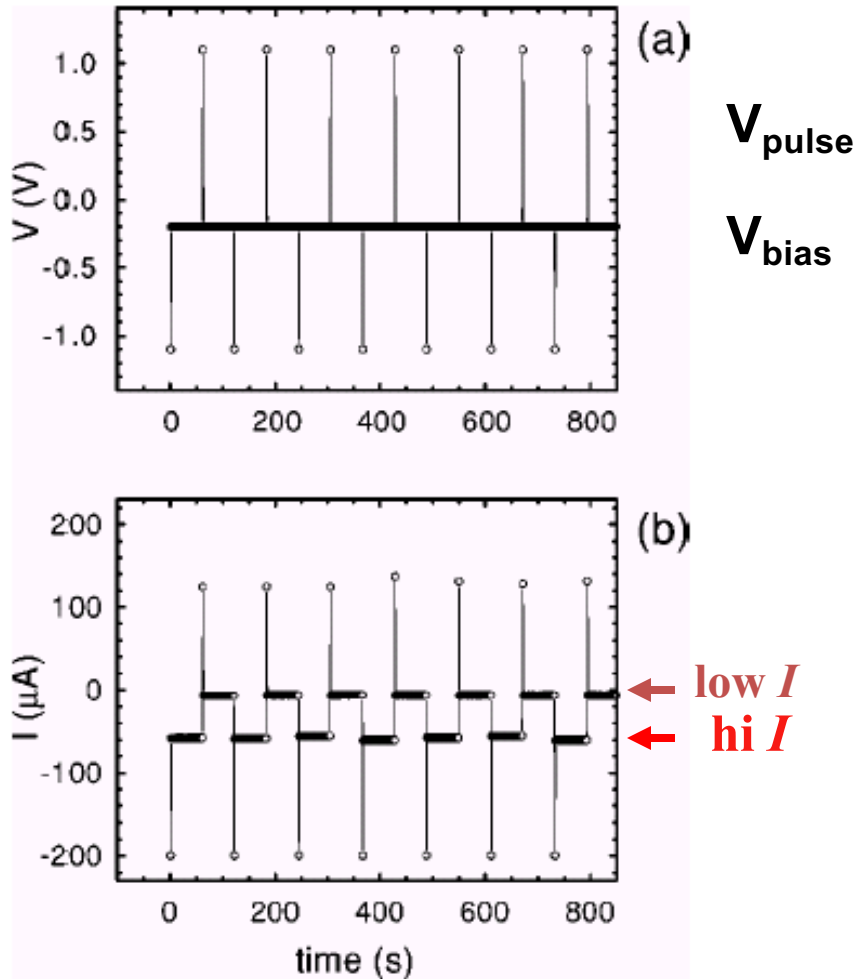
PHYSICAL REVIEW LETTERS

11 NOVEMBER 1968

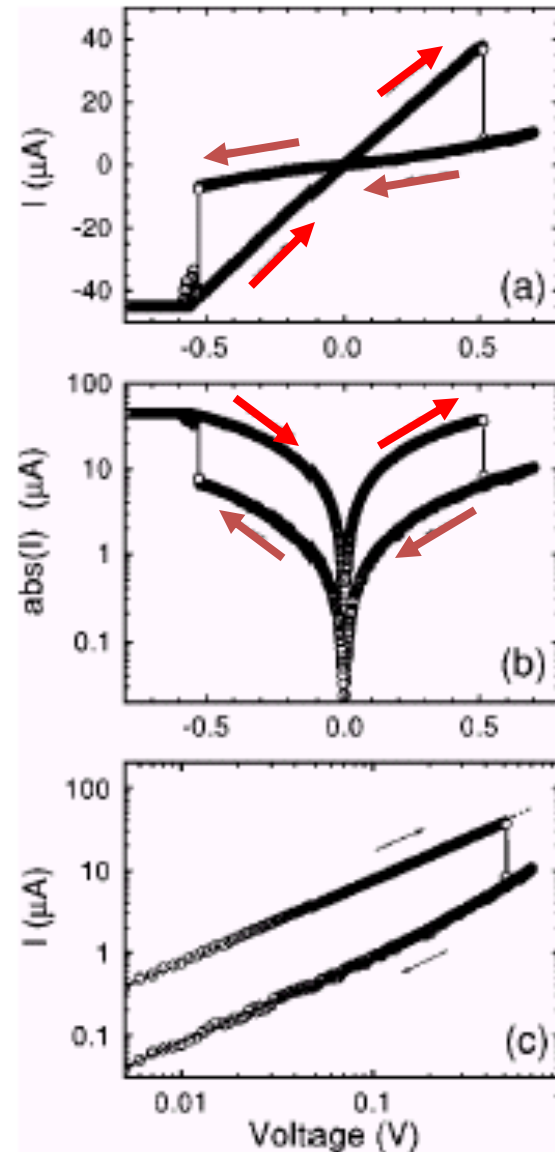
REVERSIBLE ELECTRICAL SWITCHING PHENOMENA IN DISORDERED STRUCTURES

Stanford R. Ovshinsky
Energy Conversion Devices, Inc., Troy, Michigan
(Received 23 August 1968)

switching





hysteresis (I - V)



Cr-doped SrZrO
IBM group APL'00

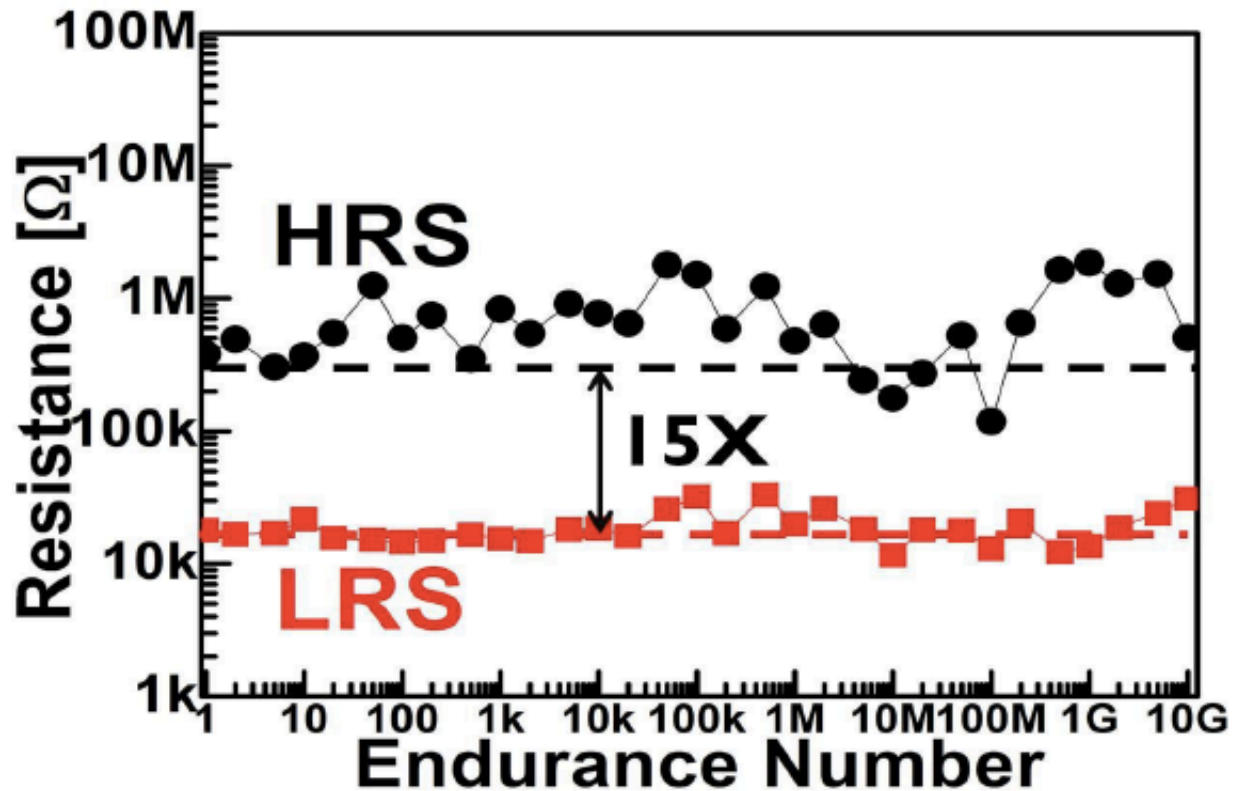
The Periodic Table of the Elements

 corresponding binary oxide that exhibits bistable resistance switching
 metal that is used for electrode

1 H																	1 H	2 He																											
3 Li	4 Be											5 B	6 C	7 N	8 O	9 F	10 Ne																												
11 Na	12 Mg											13 Al	14 Si	15 P	16 S	17 Cl	18 Ar																												
19 K	20 Ca	21 Sc	22 Ti	23 V	24 Cr	25 Mn	26 Fe	27 Co	28 Ni	29 Cu	30 Zn	31 Ga	32 Ge	33 As	34 Se	35 Br	36 Kr																												
37 Rb	38 Sr	39 Y	40 Zr	41 Nb	42 Mo	43 Tc	44 Ru	45 Rh	46 Pd	47 Ag	48 Cd	49 In	50 Sn	51 Sb	52 Te	53 I	54 Xe																												
55 Cs	56 Ba	57 La	72 Hf	73 Ta	74 W	75 Re	76 Os	77 Ir	78 Pt	79 Au	80 Hg	81 Tl	82 Pb	83 Bi	84 Po	85 At	86 Rn																												
87 Fr	88 Ra	89 Ac	104 Rf	105 Db	106 Sg	107 Bh	108 Hs	109 Mt	110	111	112		114		116		118																												
<table border="1"> <tbody> <tr> <td>58 Ce</td> <td>59 Pr</td> <td>60 Nd</td> <td>61 Pm</td> <td>62 Sm</td> <td>63 Eu</td> <td>64 Gd</td> <td>65 Tb</td> <td>66 Dy</td> <td>67 Ho</td> <td>68 Er</td> <td>69 Tm</td> <td>70 Yb</td> <td>71 Lu</td> </tr> <tr> <td>90 Th</td> <td>91 Pa</td> <td>92 U</td> <td>93 Np</td> <td>94 Pu</td> <td>95 Am</td> <td>96 Cm</td> <td>97 Bk</td> <td>98 Cf</td> <td>99 Es</td> <td>100 Fm</td> <td>101 Md</td> <td>102 No</td> <td>103 Lr</td> </tr> </tbody> </table>																		58 Ce	59 Pr	60 Nd	61 Pm	62 Sm	63 Eu	64 Gd	65 Tb	66 Dy	67 Ho	68 Er	69 Tm	70 Yb	71 Lu	90 Th	91 Pa	92 U	93 Np	94 Pu	95 Am	96 Cm	97 Bk	98 Cf	99 Es	100 Fm	101 Md	102 No	103 Lr
58 Ce	59 Pr	60 Nd	61 Pm	62 Sm	63 Eu	64 Gd	65 Tb	66 Dy	67 Ho	68 Er	69 Tm	70 Yb	71 Lu																																
90 Th	91 Pa	92 U	93 Np	94 Pu	95 Am	96 Cm	97 Bk	98 Cf	99 Es	100 Fm	101 Md	102 No	103 Lr																																

Astonishingly universal!

Fast commutation speed nsec



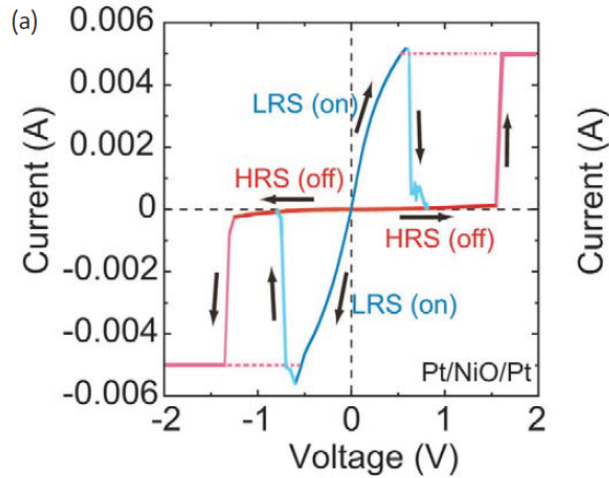
By balancing the SET pulse $W_L=1V, B_L=1.8V, 5ns$ and RESET pulse $W_L=3V, S_L=1.8V, 10ns$, 10^{10} pulse endurance could be achieved on 40nm Hf/HfO₂ ITIR devices.

HfO2

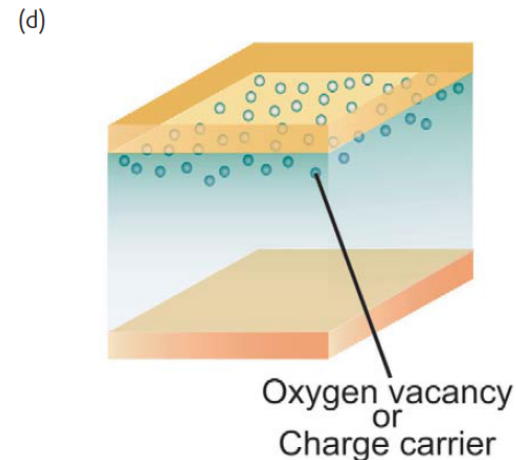
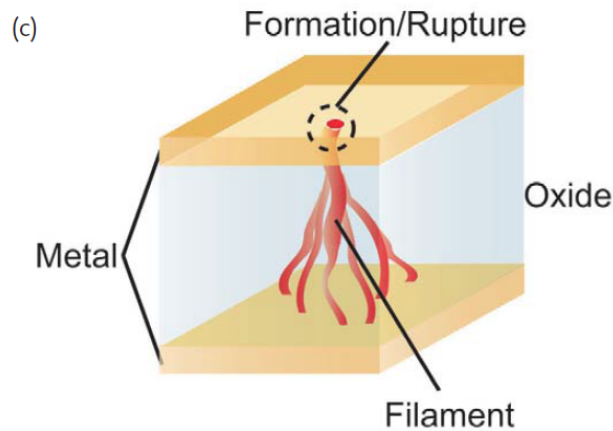
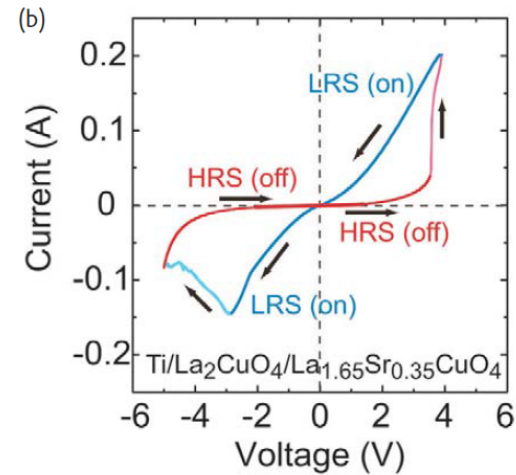
YY Chen et al 2012

There are two main types of Non-volatile Resistive Switching:

Non-Polar



Bi-Polar



Mechanism is due to semipermanent structural transformations

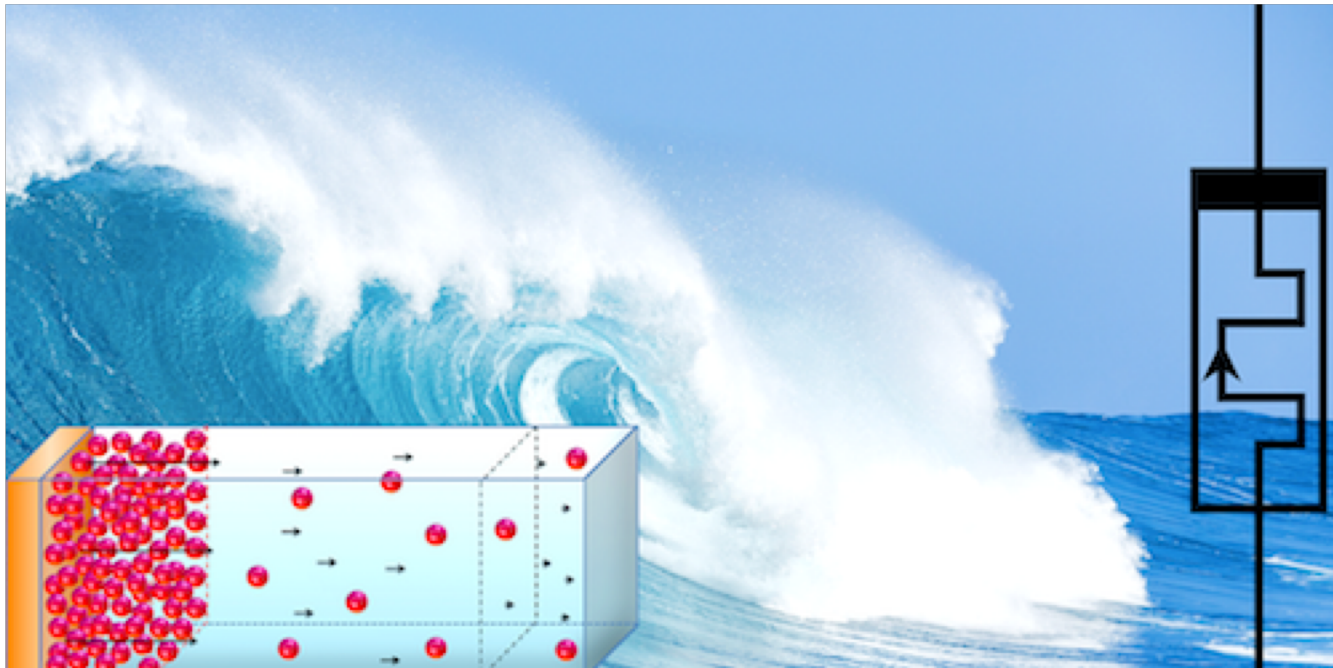
Realize « synapses »

Some new theoretical insight

Shock Waves and Commutation Speed of Memristors

Shao, Tesler, Dobrosavljevic, MR; Phys. Rev. X 6, 011028 (2016)

Physics Synopsis: Waves That Shock Resistance

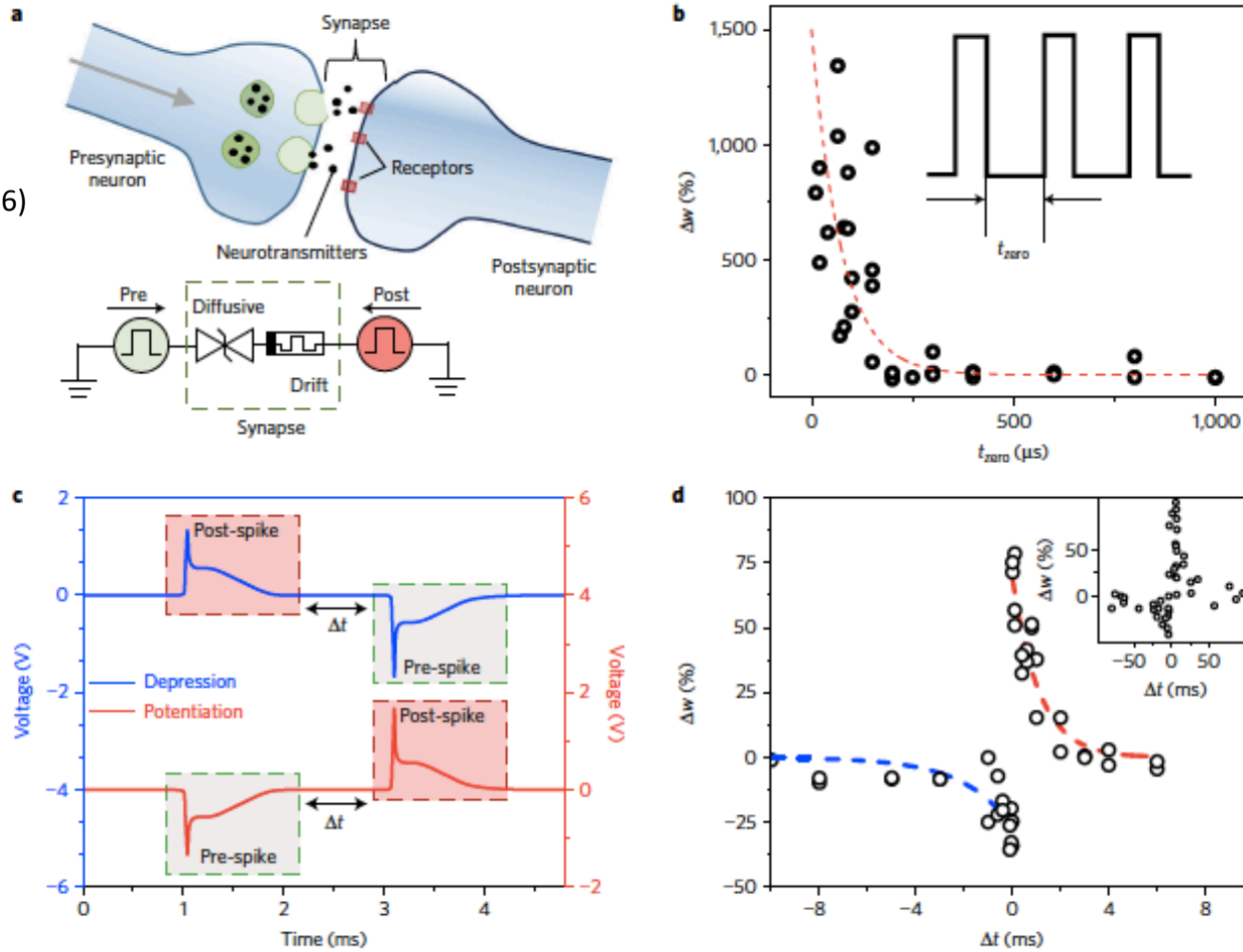


A shockwave of oxygen vacancies

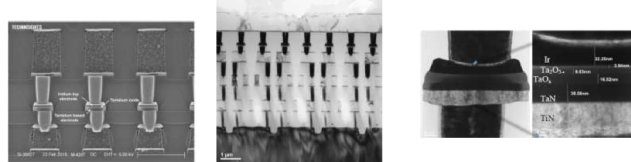
STDP

TaOx

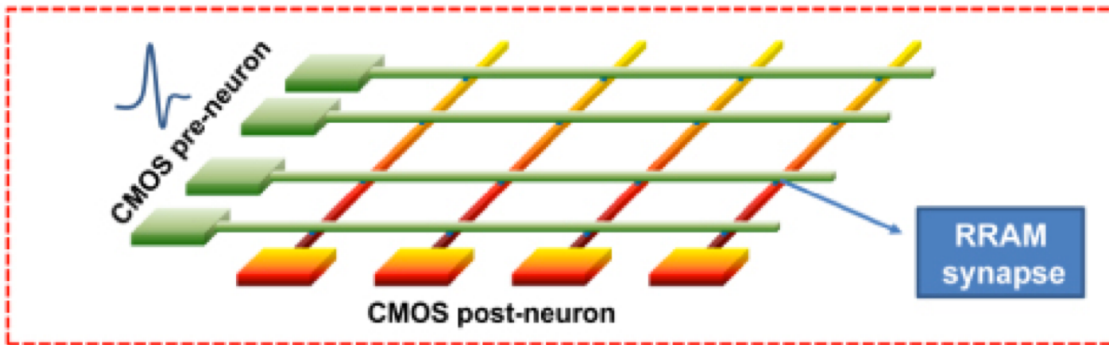
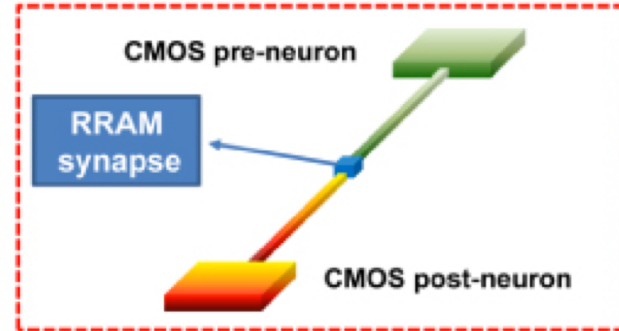
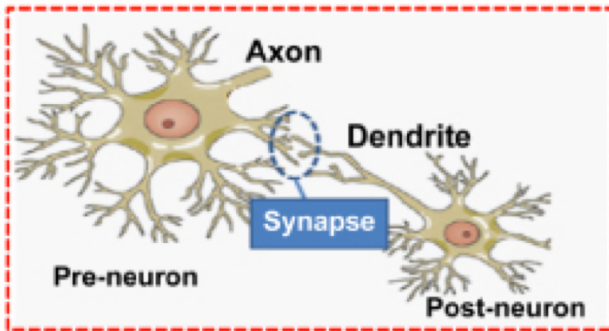
Z. Wang Nat Mat (2016)



RRAM products: Panasonic MN101L



MN101L is an 8-bit microcontroller with 64kB memory
 Operating T range: -40° C to +85° C
 62kB of memory rated for 1e3 program cycles
 2kB of memory designated for data area and rated separately for 1e5 program cycles.

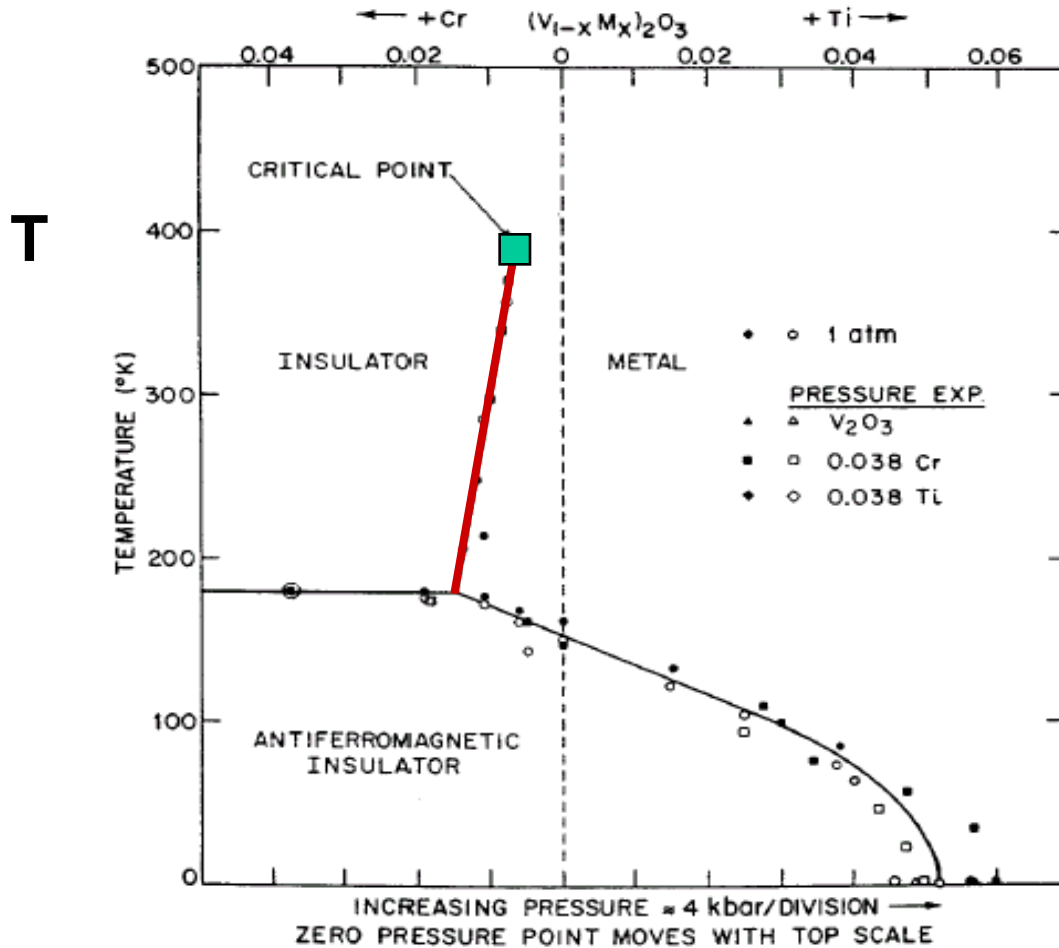


Strong correlation effects?

2 – Volatile Resistive Switching
in 3-dimensional **Mott** insulators

May realize neurons

The classic example: Mott transition in V_2O_3



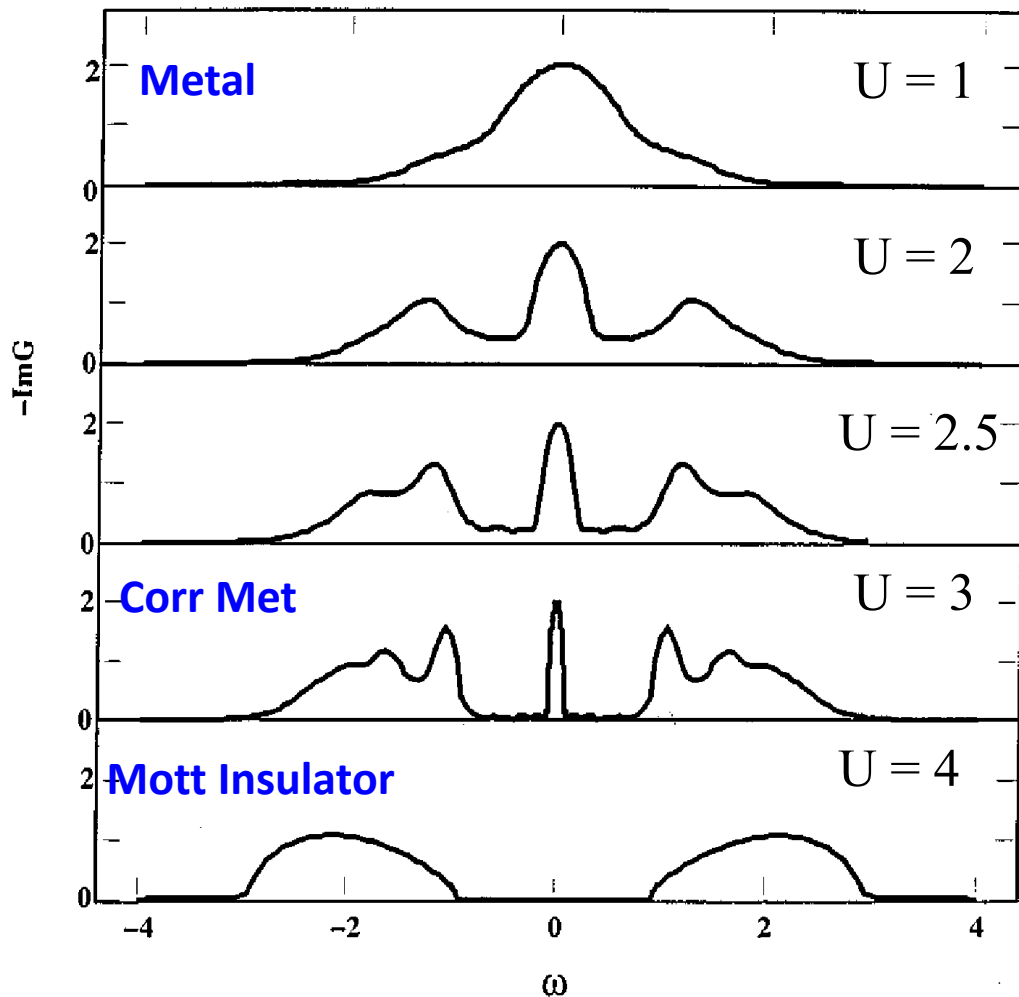
pressure or chemical substitution

DMFT of the Mott – Hubbard transition

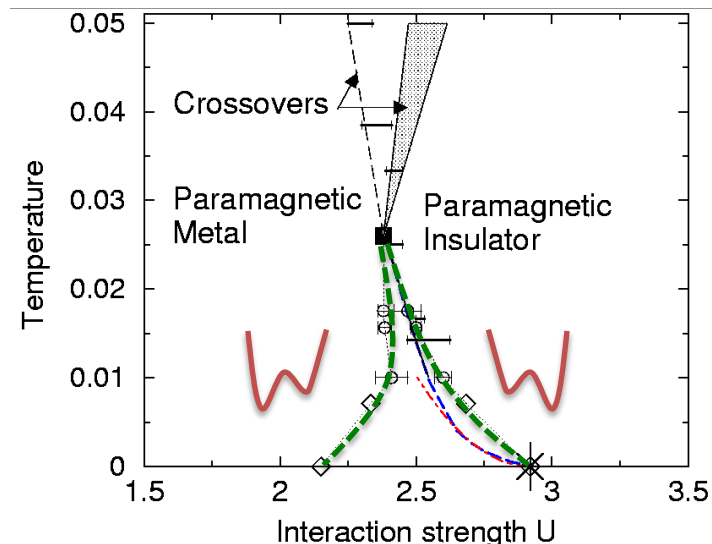
Georges, Kotliar, Krauth & MR, RMP '96

Georges, Kotliar PRB '92

Zhang, MR, Kotliar PRL '92



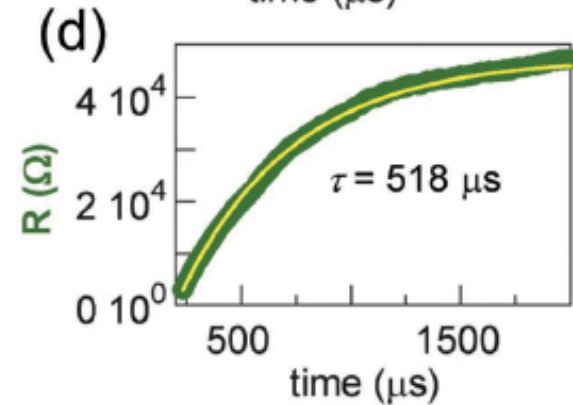
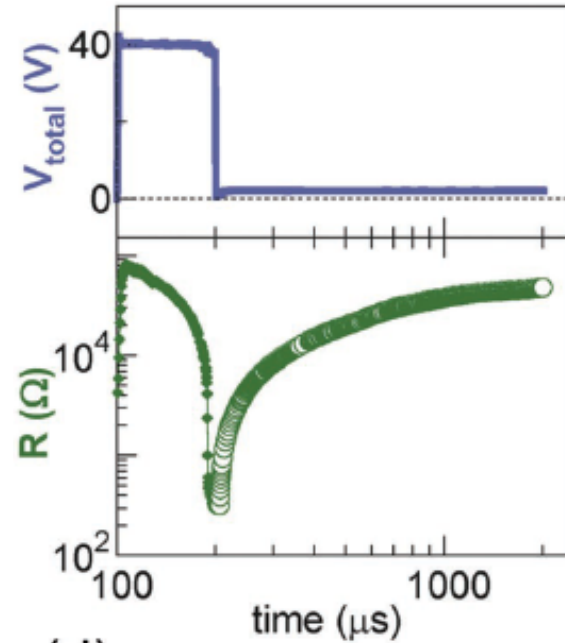
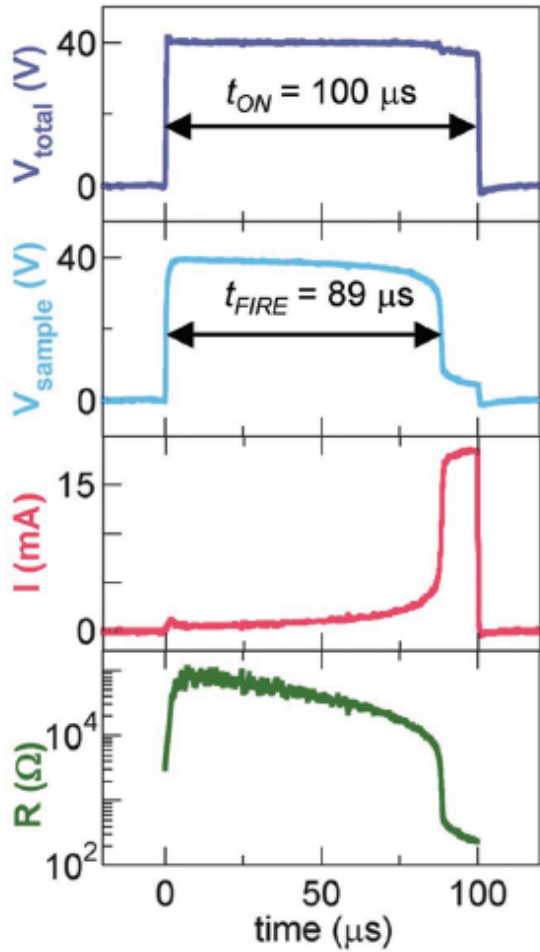
Coexistence region: 2 solutions



Mott physics + electronics
« Mottronics »

Applying strong E-fields to
Mott systems

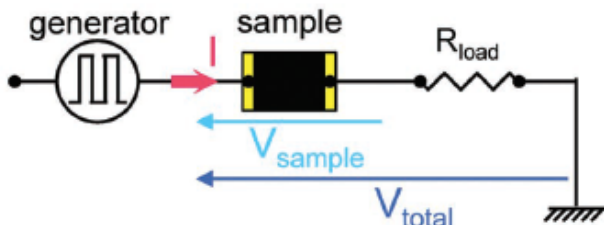
Volatile RS in 3D Mott insulators



Perfectly reproducible!!

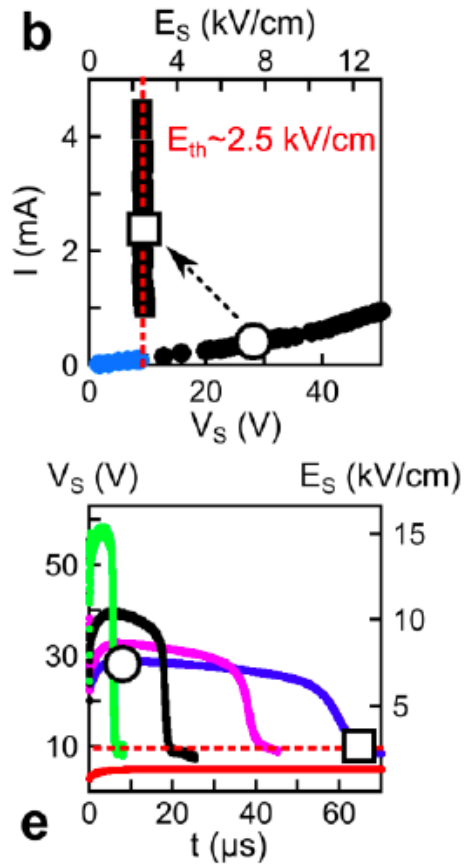
GaTa₄Se₈ single x-tal @ 74K

A. Camjayi, et al PRL 2014



Volatile RS in 3D Mott insulators

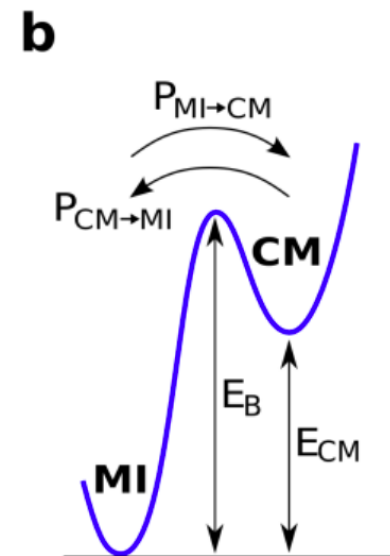
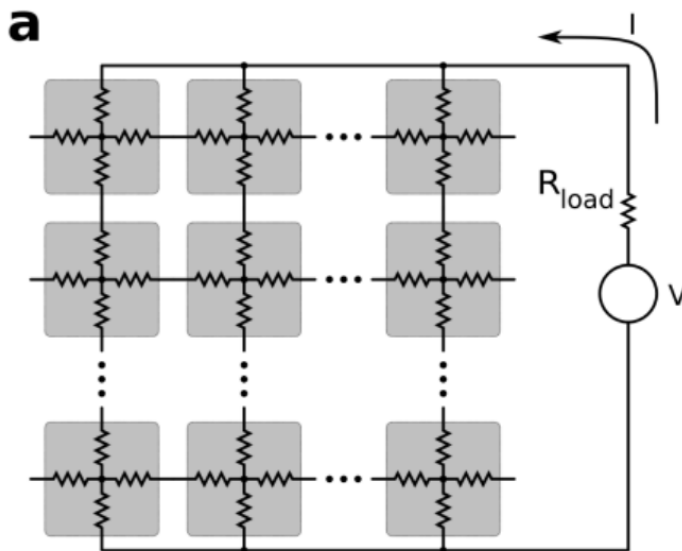
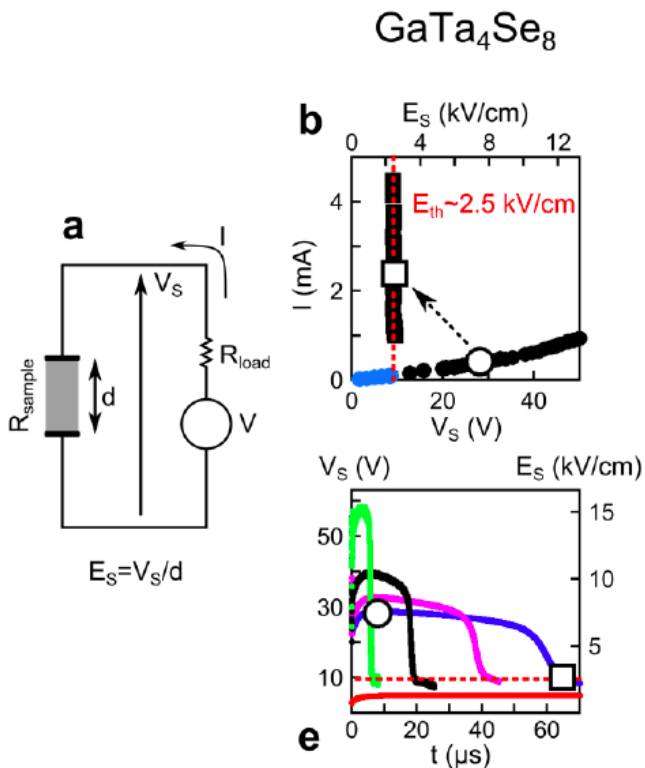
GaTa₄Se₈



Model of the Mott resistive transition

(with inspiration from DMFT)

P. Stolar et al Adv. Mater. (2013)



Two states: MI – Mott insulator

CM – Correlated metal

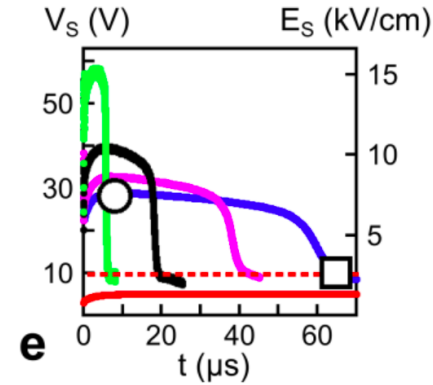
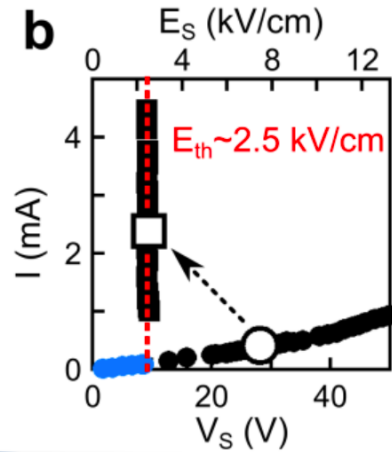
$$R_{\text{MI}} \gg R_{\text{CM}}$$

$P_{\text{MI} \rightarrow \text{CM}}$ and $P_{\text{CM} \rightarrow \text{MI}}$ are transition probabilities

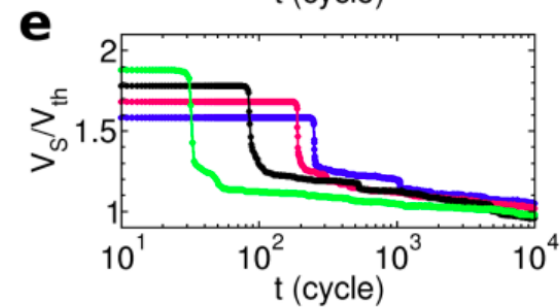
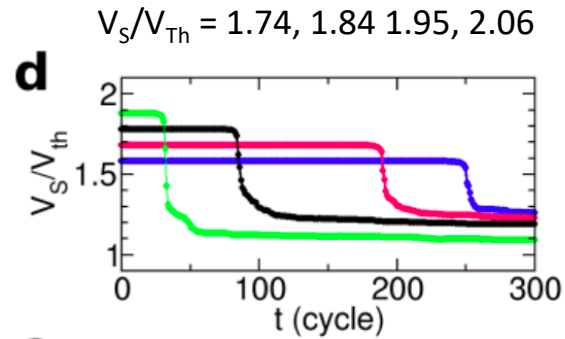
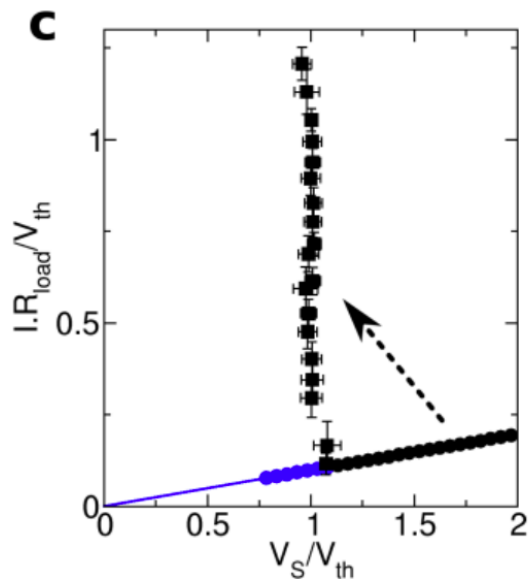
$$P_{\text{MI} \rightarrow \text{CM}} = \nu e^{-(E_B - q\Delta V)/kT} \quad P_{\text{CM} \rightarrow \text{MI}} = \nu e^{-(E_B - E_{\text{CM}})/kT}$$

Model results: Threshold Mott resistive transition

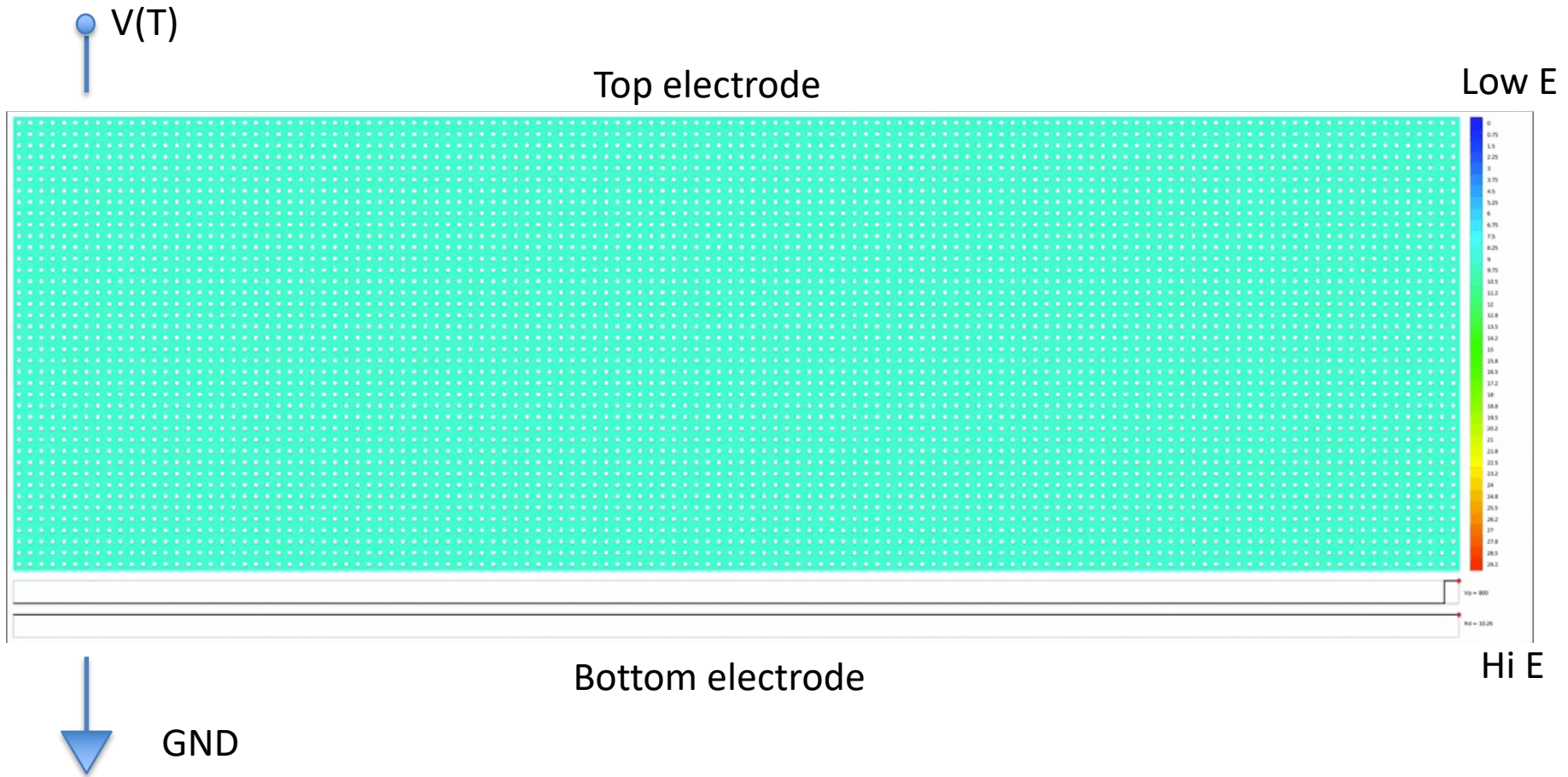
Experiment



Theory



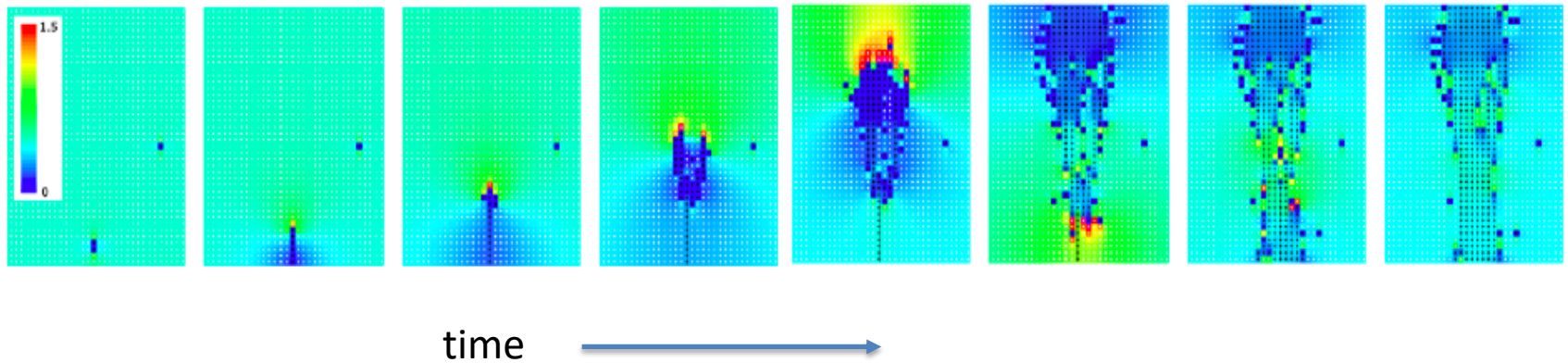
How the transition evolves in time?

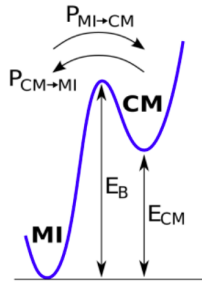


Each pixel is a cell of the resistor network model

Color intensity indicates the local ΔV drops (ie local E)

How the transition evolves in time? (snapshots)

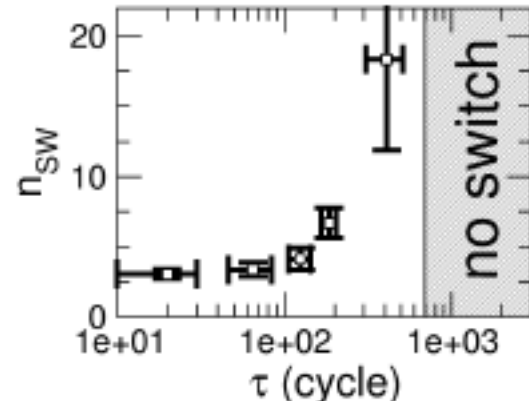
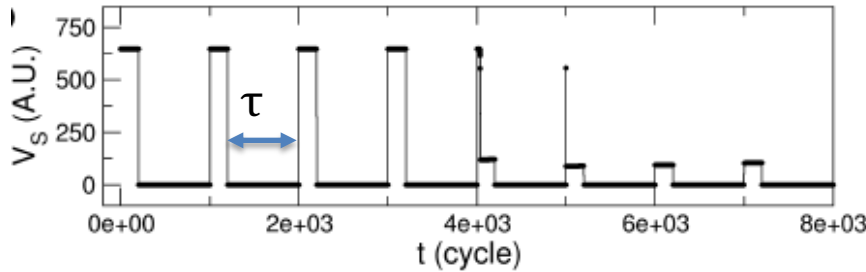




Transition rates imply the existence of a relaxation time scale t_{relax}

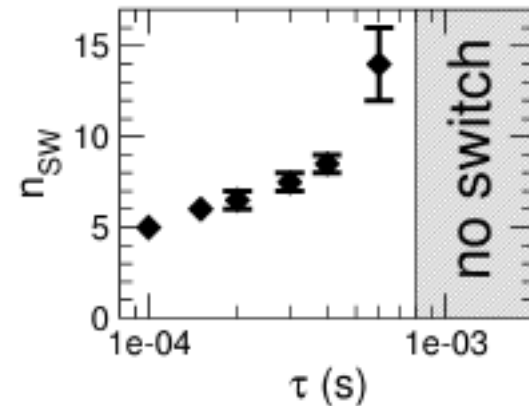
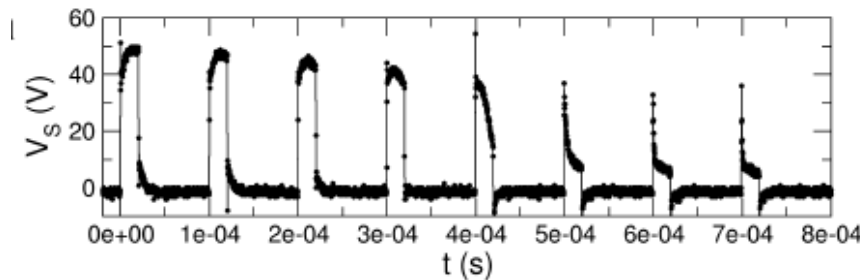
Short pulses ($< t_{delay}$) are sent at intervals $\tau < t_{relax}$

Model prediction



Transition after 5 pulses

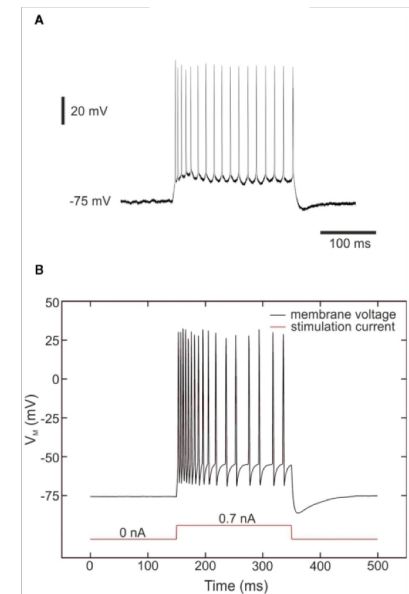
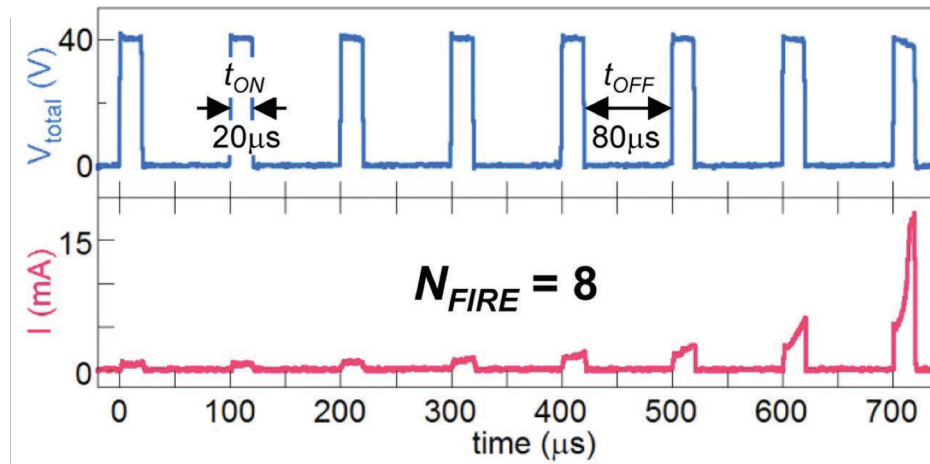
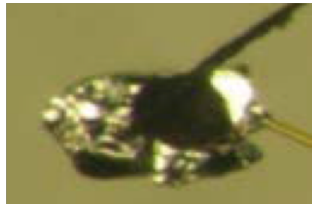
Experiment



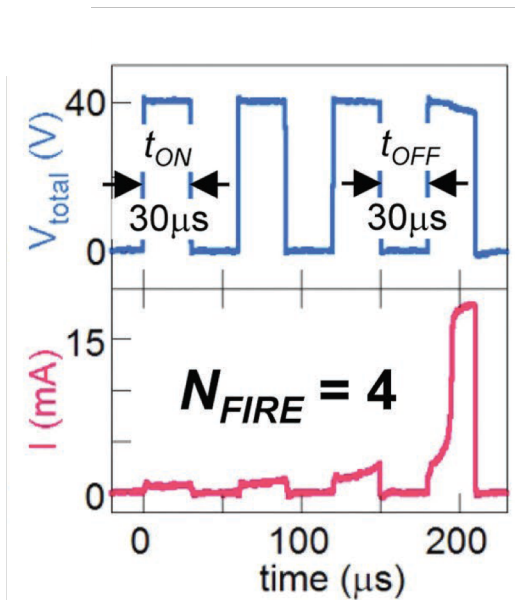
A Leaky-Integrate-and-Fire Neuron Analogue realized with a Mott insulator

P. Stoliar, MR, et al Adv Funct Mat (2017)

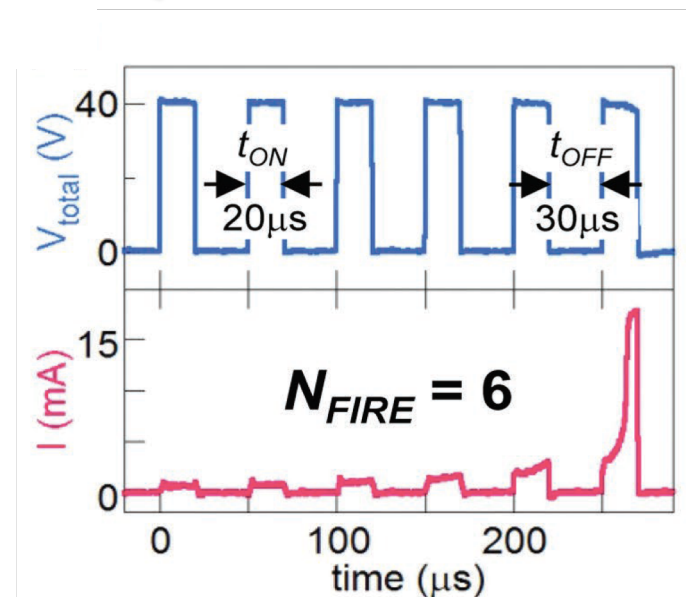
US Patent n° PCT/EP2015/058873

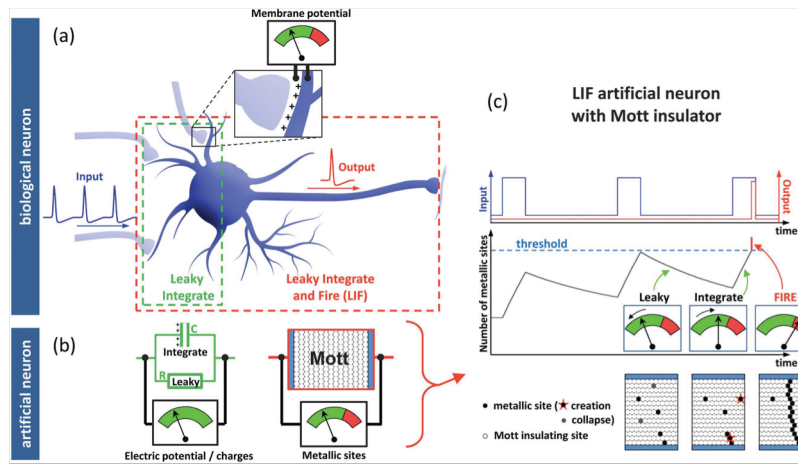


higher frequency



higher strength





	LIF model	Mott LIF neuron
Integrated variable	Membrane potential v	Fraction metallic regions n_{CM}
Model	$\frac{\partial}{\partial t} v = -v \frac{1}{RC} + \frac{w}{C} s(t)$	$\frac{\partial}{\partial t} n_{CM} = -n_{CM} P_{CM \rightarrow MI} + A p(t)$
Input variable	Dirac delta function	Voltage pulse
Output variable	Not defined	Current pulse
Leaking time constant	RC	$1/P_{CM \rightarrow MI}$
Synaptic input	$s = \sum_i \delta(t - t_i)$	$p = \sum_i [H(t - t_i) - H(t - t_i - t_{ON})]$
Spike contribution	w/C	$A t_{ON}$
Number of pulses for FIRE	$N_{FIRE} = \text{ceiling} \left(1 - \frac{\ln \left[e^{t_{OFF}/\tau} - \frac{t_{FIRE}}{t_{ON}} (e^{t_{OFF}/\tau} - 1) \right]}{t_{OFF}/\tau} \right)$	

Summary

- We now have artificial synapses and neurons made of simple 2 terminal oxide devices whose physics is based on the physical phenomenon of resistive switching
- Mott insulators (with small gap) can realize LIF-neurons
- Theoretical modeling may provide useful guidance for experiments
- The way is open for neuromorphic applications

Collaboration with the group at IMN (Nantes),
P. Stoliar (AIST Japan)

Volatile Resistive Switching in Mott insulators:

V. Guiot et al, Nat Comm (2013)

P. Stoliar et al., Adv. Mat. (2013)

A. Camjayi et al., Phys Rev Lett (2014)

P. Stoliar et al., Phys. Rev. B (2014).

E. Janod et al Adv Func Mat (2016) **Review**

P. Stoliar et al. Adv Func Mat (2017)

P. Diener et al. Phys. Rev. Lett. (2018)

Job opportunity

Postdoc position is available

marcelo.rozenberg@u-psud.fr

Funded by DOE – US

New 4-year project with the group of Ivan Schuller at U. California (San Diego)

Recent work

On recovery from the E-MIT

Tesler et al. *Phys. Rev. Applied* **10**, 054001 (2018). Editor's suggestion

J. Del Valle et al. *Nature* (in press)